

# Si/SiC Hybrid Module – EliteSiC, 3-channel, 1200 V IGBT + SiC Boost, 80 A IGBT and 20 A SiC Diode, Q1 Package

## NXH240B120H3Q1PG, NXH240B120H3Q1PG-R, NXH240B120H3Q1SG

The NXH240B120H3Q1PG is a case power module containing a three channel BOOST stage. The integrated field stop trench IGBTs and SiC Diodes provide lower conduction losses and switching losses, enabling designers to achieve high efficiency and superior reliability.

### Features

- 1200 V Ultra Field Stop IGBTs
- Low Reverse Recovery and Fast Switching SiC Diodes
- Low Inductive Layout
- Press-fit Pins
- Thermistor

### Typical Applications

- Solar Inverters
- ESS

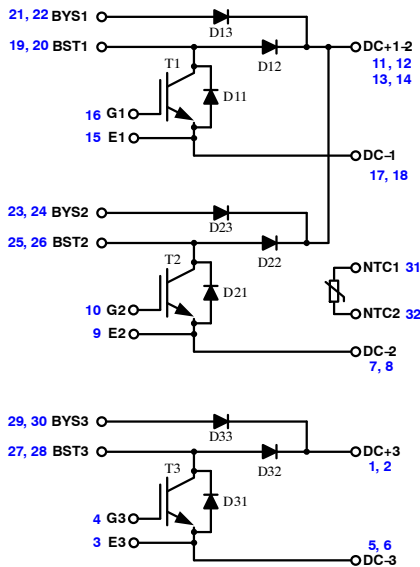
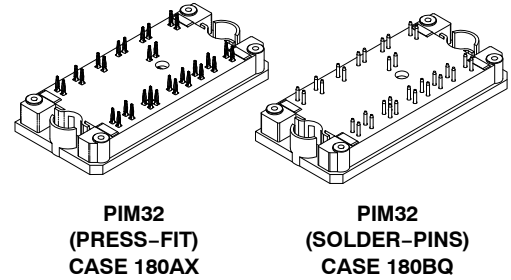
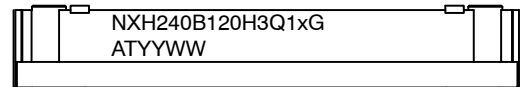


Figure 1. Schematic Diagram



### MARKING DIAGRAM



NXH240B120H3Q1xG = Specific Device Code

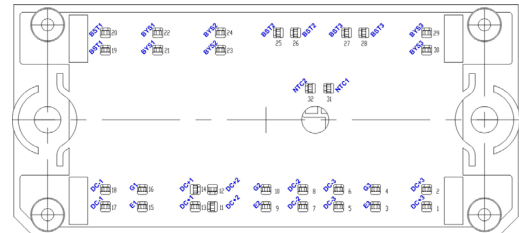
x = P or S

G = Pb-Free Package

AT = Assembly & Test Site Code

YYWW = Year and Work Week Code

### PIN ASSIGNMENTS



### ORDERING INFORMATION

See detailed ordering and shipping information in the dimensions section on page 12 of this data sheet.

# NXH240B120H3Q1PG, NXH240B120H3Q1PG-R, NXH240B120H3Q1SG

**Table 1. MAXIMUM RATINGS** (Note 1)

Rating	Symbol	Value	Unit
<b>IGBT (T1, T2, T3)</b>			
Collector-Emitter Voltage	$V_{CES}$	1200	V
Gate-Emitter Voltage	$V_{GE}$	$\pm 20$	V
Continuous Collector Current @ $T_h = 80^\circ\text{C}$ ( $T_J = 175^\circ\text{C}$ )	$I_C$	68	A
Pulsed Collector Current ( $T_J = 175^\circ\text{C}$ )	$I_{Cpulse}$	204	A
Maximum Power Dissipation ( $T_J = 175^\circ\text{C}$ )	$P_{tot}$	158	W
Minimum Operating Junction Temperature	$T_{JMIN}$	-40	$^\circ\text{C}$
Maximum Operating Junction Temperature	$T_{JMAX}$	150	$^\circ\text{C}$

**PROTECTION DIODE (D11, D21, D31)**

Peak Repetitive Reverse Voltage	$V_{RRM}$	1200	V
Continuous Forward Current @ $T_h = 80^\circ\text{C}$ ( $T_J = 150^\circ\text{C}$ )	$I_F$	30	A
Repetitive Peak Forward Current ( $T_J = 150^\circ\text{C}$ )	$I_{FRM}$	120	A
Maximum Power Dissipation ( $T_J = 150^\circ\text{C}$ )	$P_{tot}$	44	W
Minimum Operating Junction Temperature	$T_{JMIN}$	-40	$^\circ\text{C}$
Maximum Operating Junction Temperature	$T_{JMAX}$	150	$^\circ\text{C}$

**SILICON CARBIDE BOOST DIODE (D12, D22, D32)**

Peak Repetitive Reverse Voltage	$V_{RRM}$	1200	V
Continuous Forward Current @ $T_h = 80^\circ\text{C}$ ( $T_J = 175^\circ\text{C}$ )	$I_F$	25	A
Repetitive Peak Forward Current ( $T_J = 175^\circ\text{C}$ )	$I_{FRM}$	75	A
Maximum Power Dissipation ( $T_J = 175^\circ\text{C}$ )	$P_{tot}$	73	W
Minimum Operating Junction Temperature	$T_{JMIN}$	-40	$^\circ\text{C}$
Maximum Operating Junction Temperature	$T_{JMAX}$	175	$^\circ\text{C}$

**BYPASS DIODE (D13, D23, D33)**

Peak Repetitive Reverse Voltage	$V_{RRM}$	1200	V
Continuous Forward Current @ $T_h = 80^\circ\text{C}$ ( $T_J = 150^\circ\text{C}$ )	$I_F$	42	A
Repetitive Peak Forward Current ( $T_J = 150^\circ\text{C}$ )	$I_{FRM}$	126	A
Maximum Power Dissipation ( $T_J = 150^\circ\text{C}$ )	$P_{tot}$	50	W
Minimum Operating Junction Temperature	$T_{JMIN}$	-40	$^\circ\text{C}$
Maximum Operating Junction Temperature	$T_{JMAX}$	150	$^\circ\text{C}$

**THERMAL PROPERTIES**

Storage Temperature range	$T_{stg}$	-40 to 150	$^\circ\text{C}$
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**INSULATION PROPERTIES**

Isolation test voltage, $t = 1$ sec, 60 Hz	$V_{is}$	3000	$V_{RMS}$
Creepage distance		12.7	mm

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Refer to ELECTRICAL CHARACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.

**Table 2. RECOMMENDED OPERATING RANGES**

Rating	Symbol	Min	Max	Unit
Module Operating Junction Temperature	$T_J$	-40	150	$^\circ\text{C}$

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

# NXH240B120H3Q1PG, NXH240B120H3Q1PG-R, NXH240B120H3Q1SG

**Table 3. ELECTRICAL CHARACTERISTICS**  $T_J = 25^\circ\text{C}$  unless otherwise noted

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
<b>IGBT (T1, T2, T3)</b>						
Collector-Emitter Cutoff Current	$V_{GE} = 0\text{ V}, V_{CE} = 1200\text{ V}$	$I_{CES}$	-	-	400	$\mu\text{A}$
Collector-Emitter Saturation Voltage	$V_{GE} = 15\text{ V}, I_C = 80\text{ A}, T_J = 25^\circ\text{C}$	$V_{CE(sat)}$	-	1.65	2	V
	$V_{GE} = 15\text{ V}, I_C = 80\text{ A}, T_J = 150^\circ\text{C}$		-	1.85	-	
Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}, I_C = 1.0\text{ mA}$	$V_{GE(TH)}$	4.50	5.87	6.50	V
Gate Leakage Current	$V_{GE} = 20\text{ V}, V_{CE} = 0\text{ V}$	$I_{GES}$	-	-	800	nA
Turn-on Delay Time	$T_J = 25^\circ\text{C}$ $V_{CE} = 800\text{ V}, I_C = 50\text{ A}$ $V_{GE} = +15\text{ V}, -9\text{ V}, R_G = 4.3\ \Omega$	$t_{d(on)}$	-	13	-	ns
Rise Time		$t_r$	-	22	-	
Turn-off Delay Time		$t_{d(off)}$	-	262	-	
Fall Time		$t_f$	-	13	-	
Turn-on Switching Loss per Pulse		$E_{on}$	-	1258	-	
Turn off Switching Loss per Pulse	$E_{off}$	-	1277	-		
Turn-on Delay Time	$T_J = 125^\circ\text{C}$ $V_{CE} = 800\text{ V}, I_C = 50\text{ A}$ $V_{GE} = +15\text{ V}, -9\text{ V}, R_G = 4.3\ \Omega$	$t_{d(on)}$	-	32	-	ns
Rise Time		$t_r$	-	22	-	
Turn-off Delay Time		$t_{d(off)}$	-	315	-	
Fall Time		$t_f$	-	22	-	
Turn-on Switching Loss per Pulse		$E_{on}$	-	1306	-	
Turn off Switching Loss per Pulse	$E_{off}$	-	2221	-		
Input Capacitance	$V_{CE} = 20\text{ V}, V_{GE} = 0\text{ V}, f = 10\text{ kHz}$	$C_{ies}$	-	18151	-	pF
Output Capacitance		$C_{oes}$	-	345	-	
Reverse Transfer Capacitance		$C_{res}$	-	294	-	
Total Gate Charge	$V_{CE} = 600\text{ V}, I_C = 25\text{ A}, V_{GE} = \pm 15\text{ V}$	$Q_g$	-	817	-	nC
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2 Mil $\pm 2\%$ , $\lambda = 0.63\text{ W/mK}$	$R_{thJH}$	-	0.60	-	$^\circ\text{C/W}$
Thermal Resistance – chip-to-case		$R_{thJC}$	-	0.29	-	$^\circ\text{C/W}$
<b>PROTECTION DIODE (D11, D21, D31)</b>						
Diode Forward Voltage	$I_F = 30\text{ A}, T_J = 25^\circ\text{C}$	$V_F$	-	1.09	1.3	V
	$I_F = 30\text{ A}, T_J = 150^\circ\text{C}$		-	0.99	-	
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2 Mil $\pm 2\%$ , $\lambda = 0.63\text{ W/mK}$	$R_{thJH}$	-	1.60	-	$^\circ\text{C/W}$
Thermal Resistance – chip-to-case		$R_{thJC}$	-	0.98	-	$^\circ\text{C/W}$
<b>SILICON CARBIDE BOOST DIODE (D12, D22, D32)</b>						
Diode Forward Voltage	$I_F = 20\text{ A}, T_J = 25^\circ\text{C}$	$V_F$	-	1.48	1.75	V
	$I_F = 20\text{ A}, T_J = 150^\circ\text{C}$		-	1.99	-	
Reverse Recovery Time	$T_J = 25^\circ\text{C}$ $V_{CE} = 800\text{ V}, I_C = 50\text{ A}$ $V_{GE} = +15\text{ V}, -9\text{ V}, R_G = 4.3\ \Omega$	$t_{rr}$	-	21	-	ns
Reverse Recovery Charge		$Q_{rr}$	-	84	-	$\mu\text{C}$
Peak Reverse Recovery Current		$I_{RRM}$	-	7	-	A
Peak Rate of Fall of Recovery Current		$di/dt$	-	1750	-	$\text{A}/\mu\text{s}$
Reverse Recovery Energy		$E_{rr}$	-	65	-	$\mu\text{J}$
Reverse Recovery Time	$T_J = 125^\circ\text{C}$ $V_{CE} = 800\text{ V}, I_C = 50\text{ A}$ $V_{GE} = +15\text{ V}, -9\text{ V}, R_G = 4.3\ \Omega$	$t_{rr}$	-	22	-	ns
Reverse Recovery Charge		$Q_{rr}$	-	89	-	$\mu\text{C}$
Peak Reverse Recovery Current		$I_{RRM}$	-	8	-	A
Peak Rate of Fall of Recovery Current		$di/dt$	-	1800	-	$\text{A}/\mu\text{s}$
Reverse Recovery Energy		$E_{rr}$	-	99	-	$\mu\text{J}$

# NXH240B120H3Q1PG, NXH240B120H3Q1PG-R, NXH240B120H3Q1SG

**Table 3. ELECTRICAL CHARACTERISTICS**  $T_J = 25^\circ\text{C}$  unless otherwise noted

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
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**SILICON CARBIDE BOOST DIODE (D12, D22, D32)**

Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2 Mil $\pm 2\%$ , $\lambda = 0.63$ W/mK	$R_{thJH}$	–	1.30	–	$^\circ\text{C/W}$
Thermal Resistance – chip-to-case		$R_{thJC}$	–	0.85	–	$^\circ\text{C/W}$

**BYPASS DIODE (D13, D23, D33)**

Diode Forward Voltage	I <sub>F</sub> = 50 A, T <sub>J</sub> = 25 $^\circ\text{C}$	$V_F$	–	1.095	1.3	V
	I <sub>F</sub> = 50 A, T <sub>J</sub> = 150 $^\circ\text{C}$		–	1.004	–	
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2 Mil $\pm 2\%$ , $\lambda = 0.63$ W/mK	$R_{thJH}$	–	1.40	–	$^\circ\text{C/W}$
Thermal Resistance – chip-to-case		$R_{thJC}$	–	0.85	–	$^\circ\text{C/W}$

**THERMISTOR CHARACTERISTICS**

Nominal resistance	T = 25 $^\circ\text{C}$	$R_{25}$	–	5	–	k $\Omega$
Nominal resistance	T = 100 $^\circ\text{C}$	$R_{100}$	–	493.3	–	$\Omega$
Deviation of R25		$\Delta R/R$	–5	–	5	%
Power dissipation		$P_D$	–	20	–	mW
Power dissipation constant			–	1.4	–	mW/K
B-value	B(25/50), tolerance $\pm 2\%$		–	3375	–	K

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

# NXH240B120H3Q1PG, NXH240B120H3Q1PG-R, NXH240B120H3Q1SG

## TYPICAL CHARACTERISTICS – IGBT (T1, T2, T3) and Silicon Carbide Schottky Diode (D12, D22, D32)

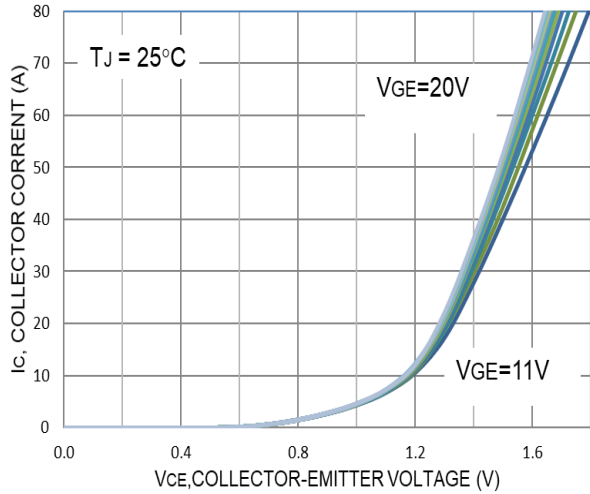


Figure 2. Typical Output Characteristics

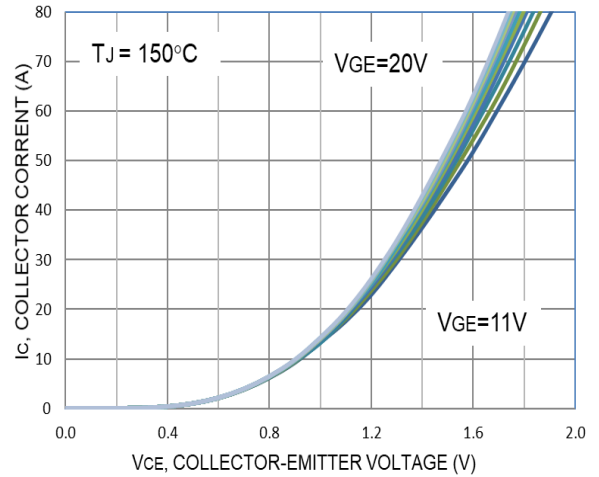


Figure 3. Typical Output Characteristics

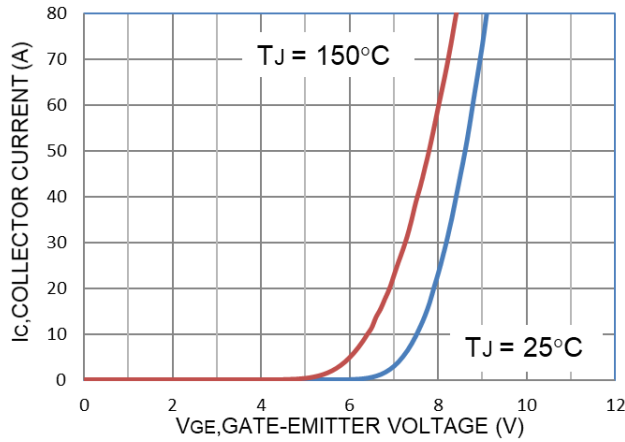


Figure 4. Typical Transfer Characteristics

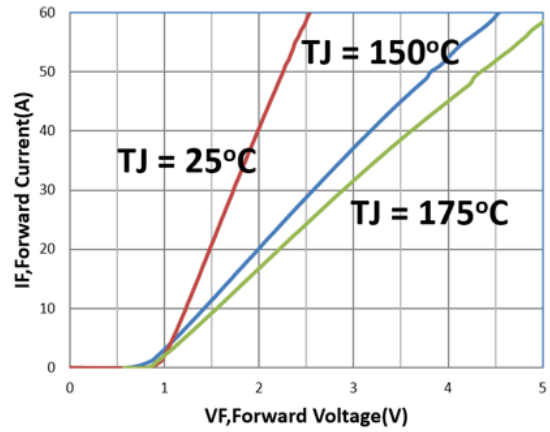


Figure 5. Diode Forward Characteristics

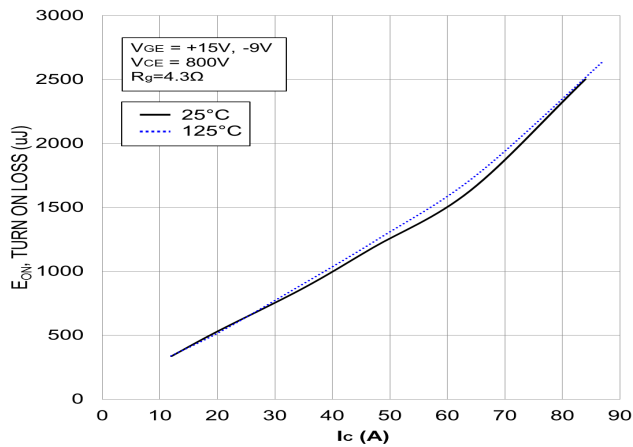


Figure 6. Typical Turn ON Loss vs.  $I_C$

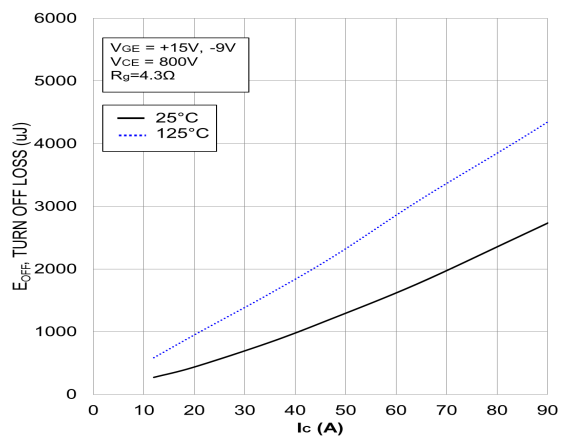


Figure 7. Typical Turn OFF Loss vs.  $I_C$

# NXH240B120H3Q1PG, NXH240B120H3Q1PG-R, NXH240B120H3Q1SG

## TYPICAL CHARACTERISTICS – IGBT (T1, T2, T3) and Silicon Carbide Schottky Diode (D12, D22, D32)

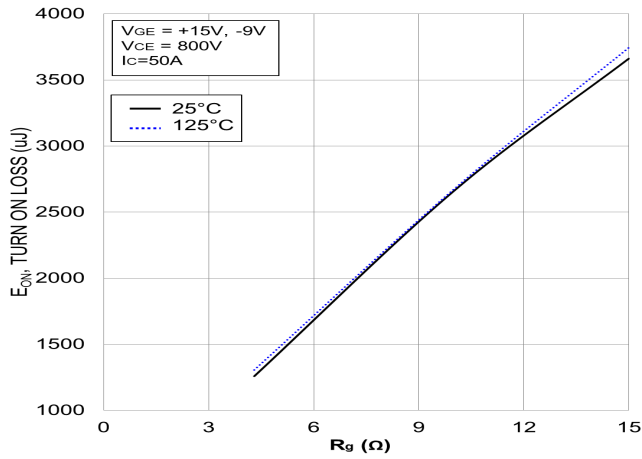


Figure 8. Typical Turn ON Loss vs.  $R_G$

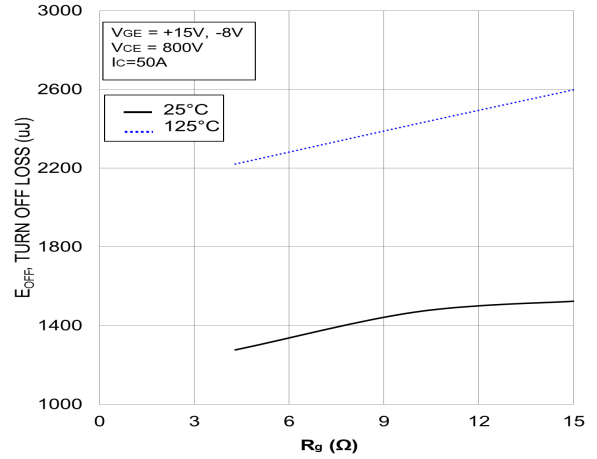


Figure 9. Typical Turn OFF Loss vs.  $R_G$

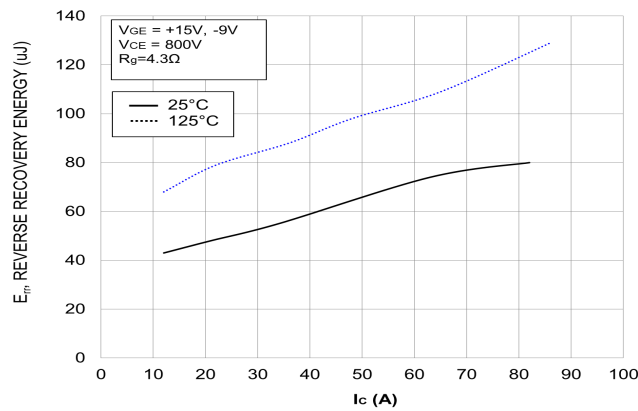


Figure 10. Typical Reverse Recovery Time vs.  $I_C$

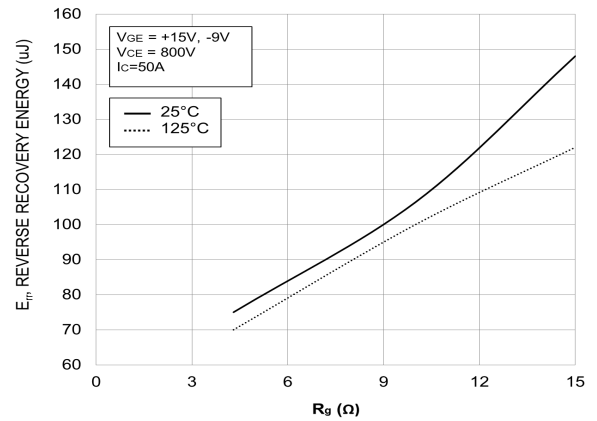


Figure 11. Typical Reverse Recovery Time vs.  $R_G$

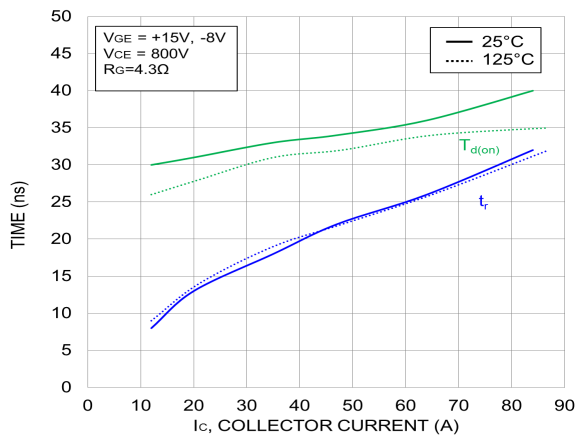


Figure 12. Typical Turn-On Switching Time vs.  $I_C$

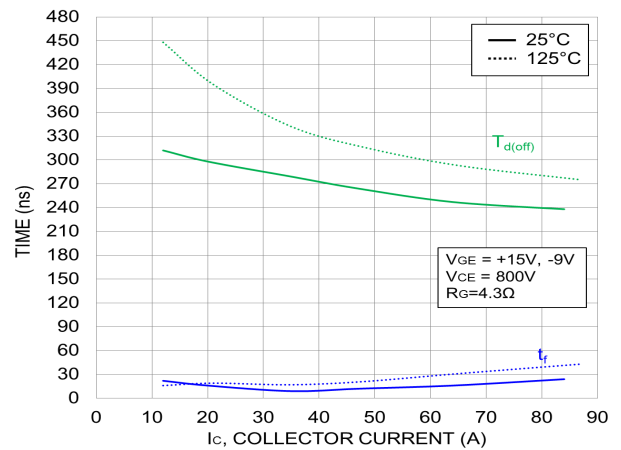


Figure 13. Typical Turn-Off Switching Time vs.  $I_C$

# NXH240B120H3Q1PG, NXH240B120H3Q1PG-R, NXH240B120H3Q1SG

## TYPICAL CHARACTERISTICS – IGBT (T1, T2, T3) and Silicon Carbide Schottky Diode (D12, D22, D32)

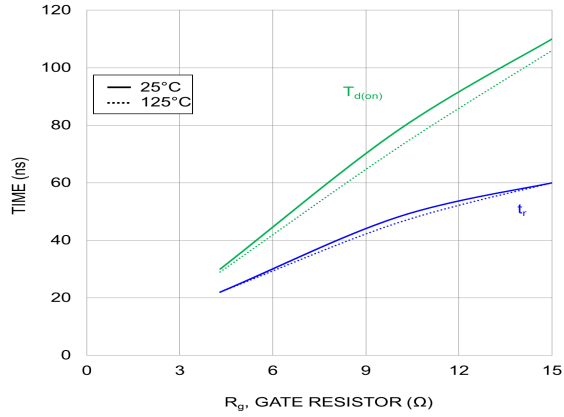


Figure 14. Typical Turn-On Switching Time vs.  $R_G$

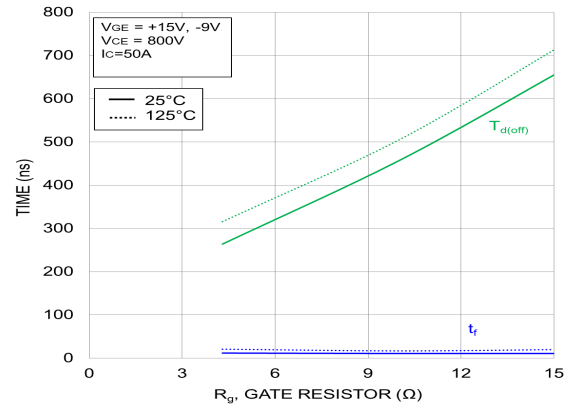


Figure 15. Typical Turn-Off Switching Time vs.  $R_G$

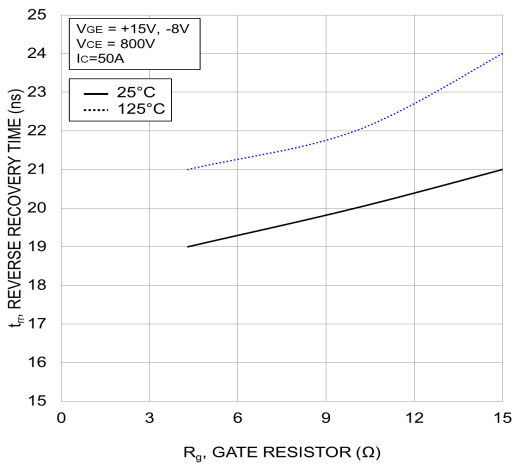


Figure 16. Typical Reverse Recovery Time vs.  $R_G$

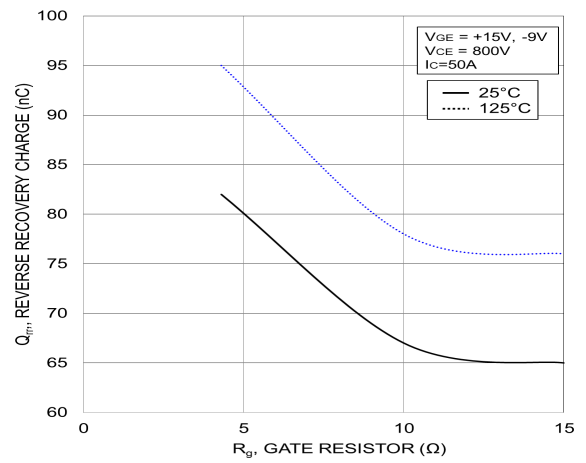


Figure 17. Typical Reverse Recovery Charge vs.  $R_G$

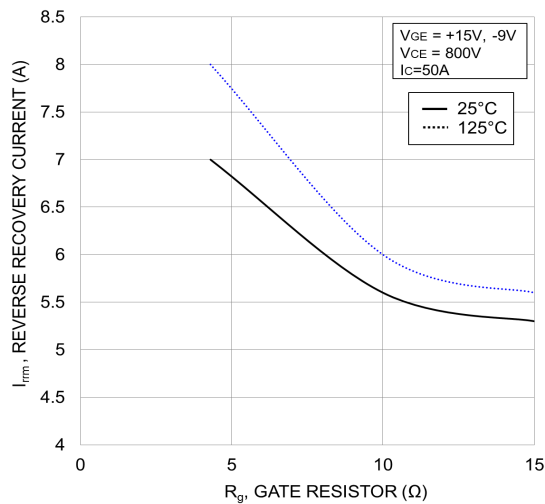


Figure 18. Typical Reverse Recovery Peak Current vs.  $R_G$

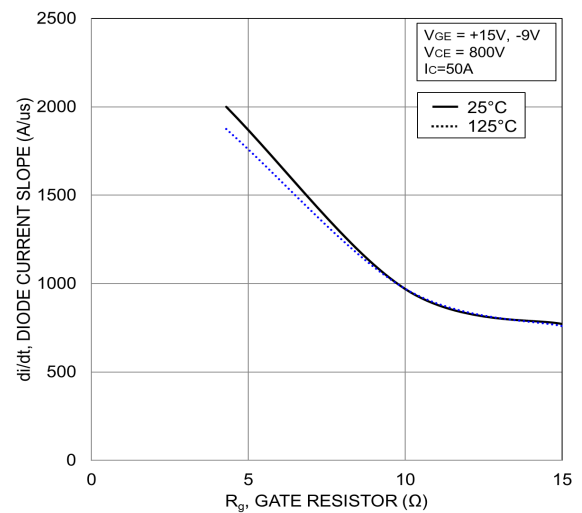


Figure 19. Typical  $di/dt$  vs.  $R_G$

# NXH240B120H3Q1PG, NXH240B120H3Q1PG-R, NXH240B120H3Q1SG

## TYPICAL CHARACTERISTICS – IGBT (T1, T2, T3) and Silicon Carbide Schottky Diode (D12, D22, D32)

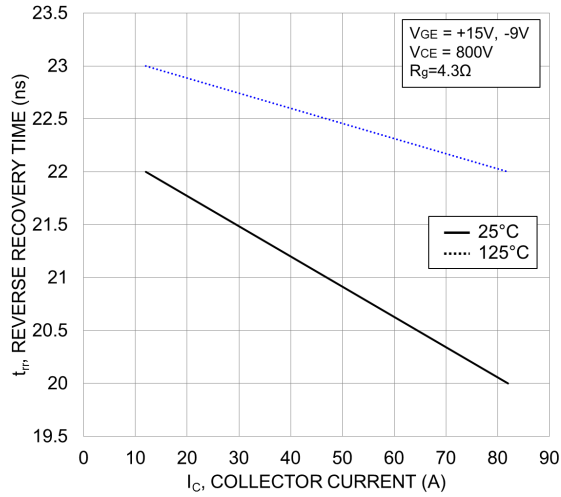


Figure 20. Typical Reverse Recovery Time vs.  $I_C$

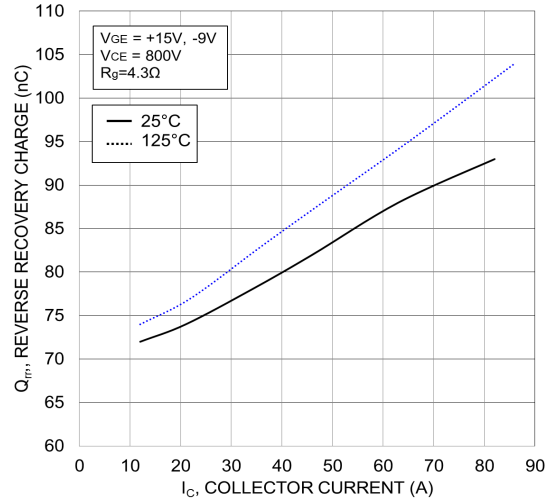


Figure 21. Typical Reverse Recovery Charge vs.  $I_C$

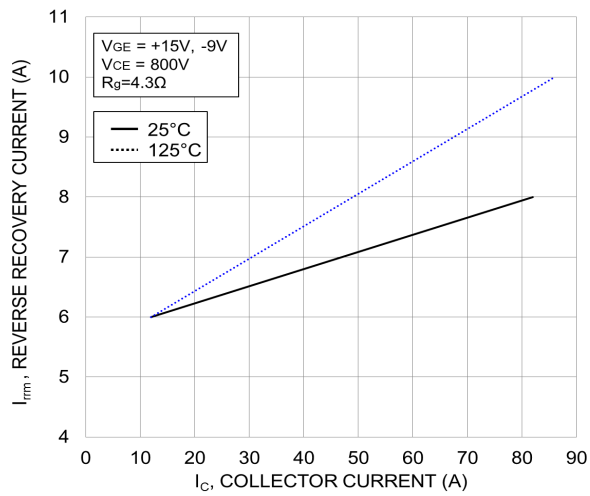


Figure 22. Typical Reverse Recovery Current vs.  $I_C$

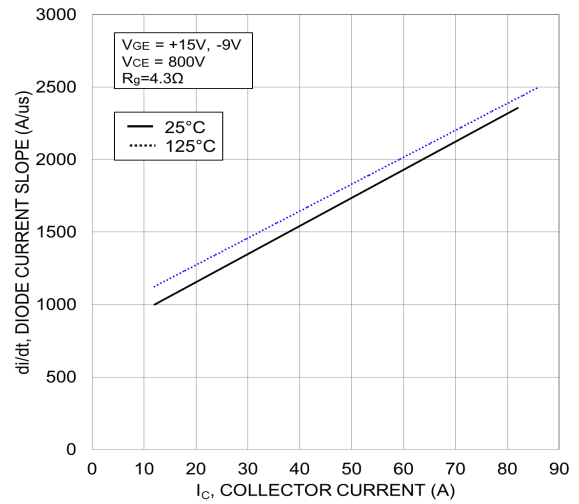


Figure 23. Typical di/dt Current Slope vs.  $I_C$

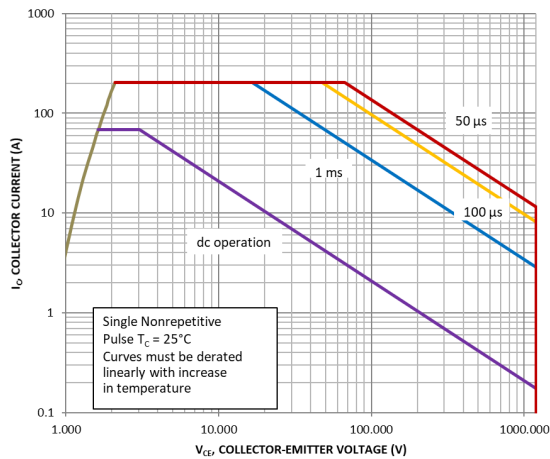


Figure 24. FBSOA

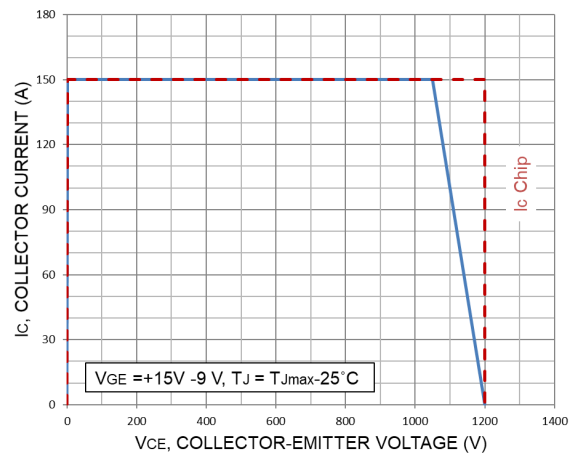


Figure 25. RBSOA



# NXH240B120H3Q1PG, NXH240B120H3Q1PG-R, NXH240B120H3Q1SG

## TYPICAL CHARACTERISTICS – IGBT (T1, T2, T3) and Silicon Carbide Schottky Diode (D12, D22, D32)

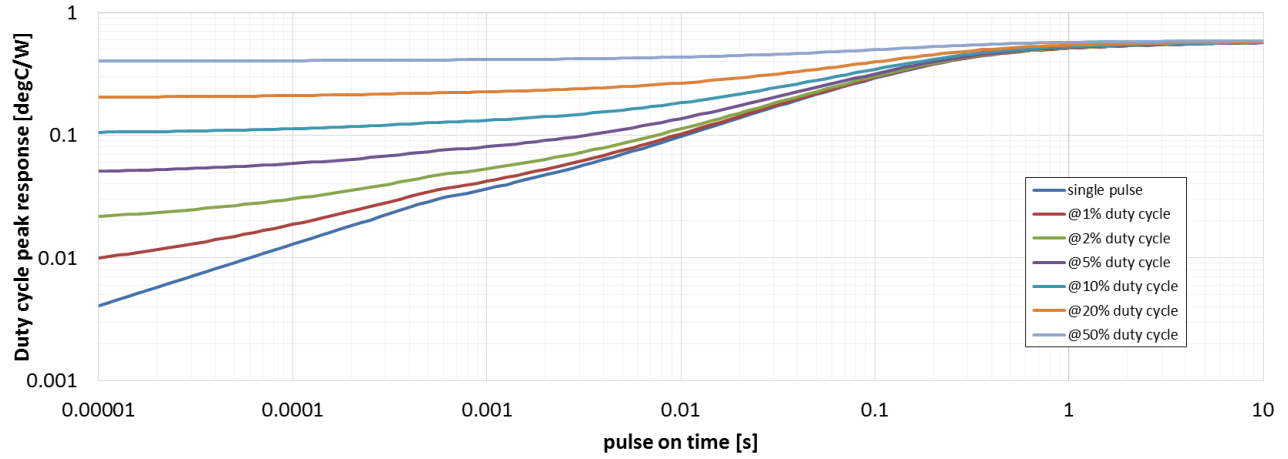


Figure 26. Transient Thermal Impedance (T1, T2, T3)

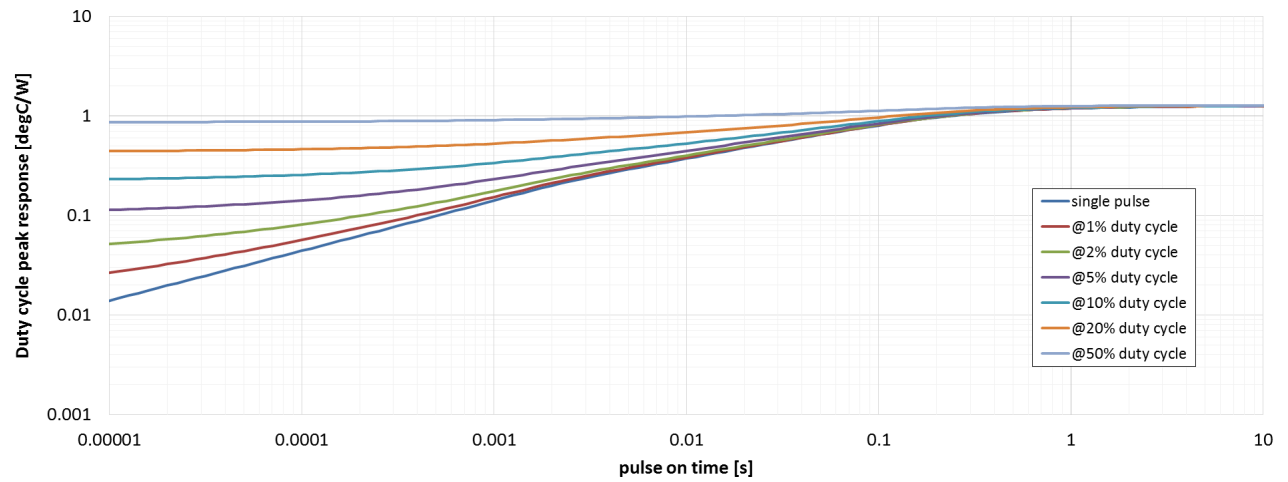


Figure 27. Transient Thermal Impedance (D12, D22, D32)

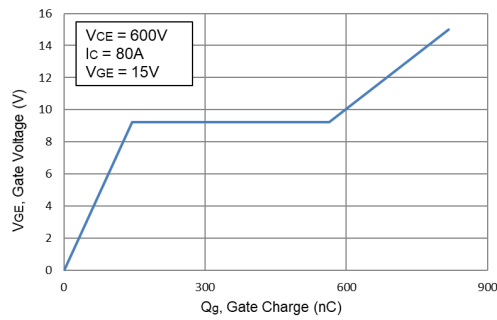


Figure 28. Gate Voltage vs. Gate Charge

TYPICAL CHARACTERISTICS – Diode (D13, D23, D33)

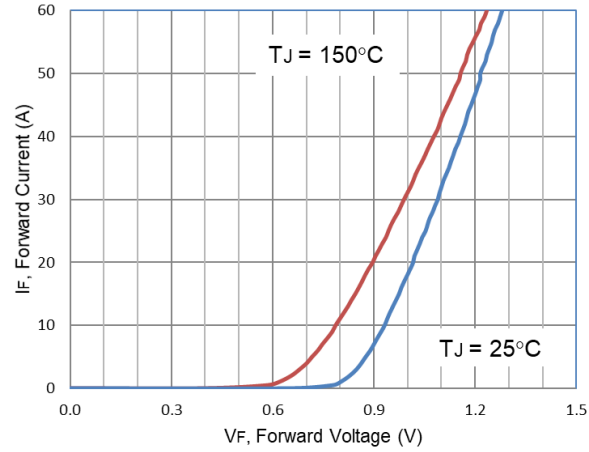


Figure 29. Diode Forward Characteristics

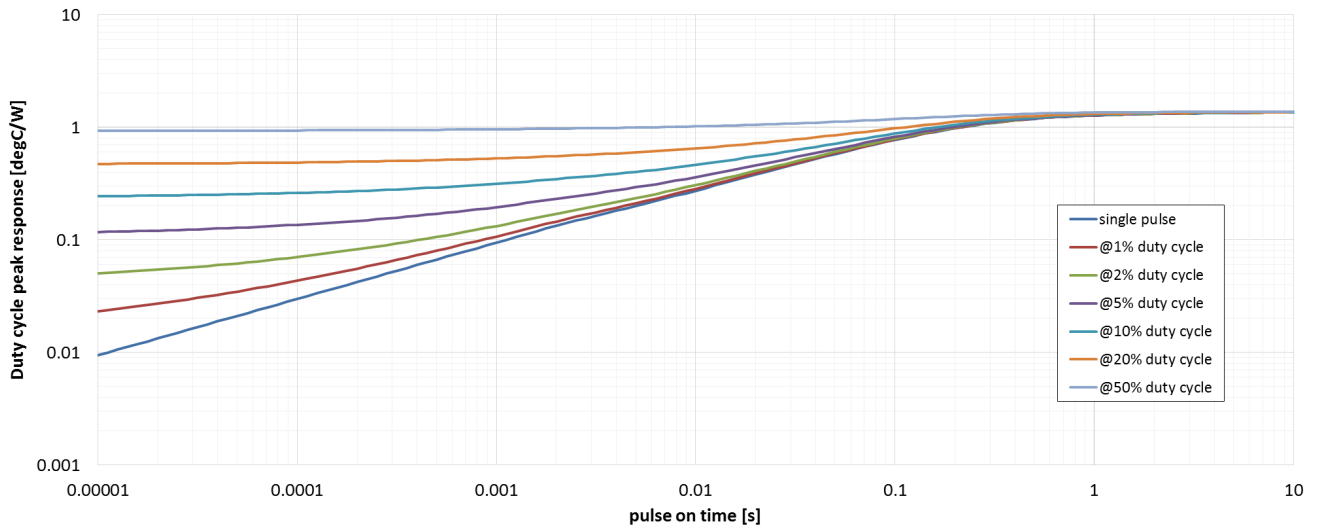


Figure 30. Transient Thermal Impedance

TYPICAL CHARACTERISTICS – Diode (D11, D21, D31)

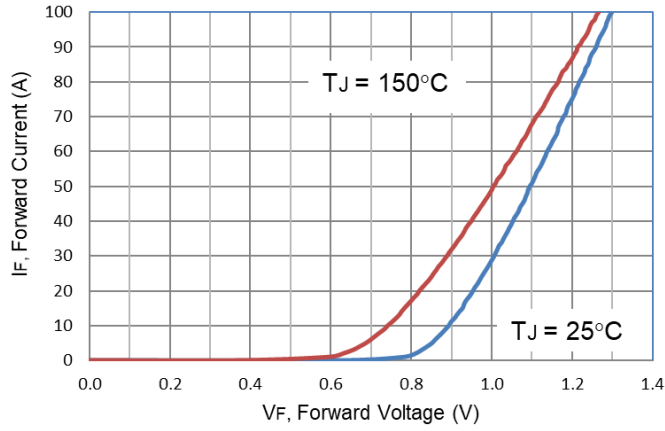


Figure 31. Diode Forward Characteristics

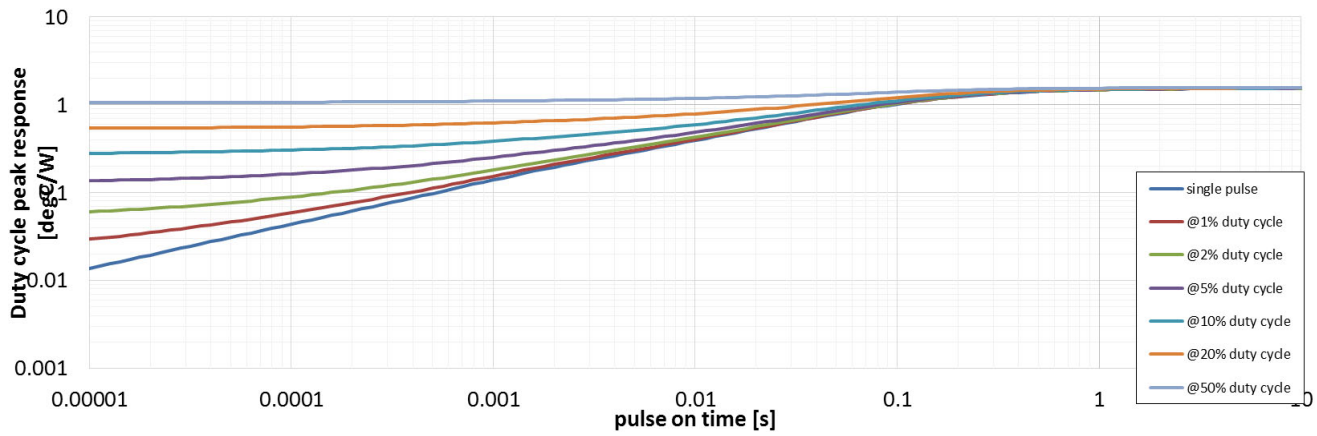


Figure 32. Transient Thermal Impedance

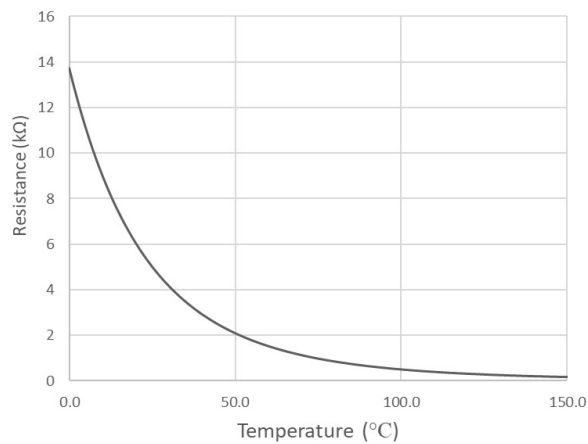


Figure 33. Thermistor Characteristic

# NXH240B120H3Q1PG, NXH240B120H3Q1PG-R, NXH240B120H3Q1SG

## ORDERING INFORMATION

Orderable Part Number	Marking	Package	Shipping
NXH240B120H3Q1PG, NXH240B120H3Q1PG-R	NXH240B120H3Q1PG, NXH240B120H3Q1PG-R	Q1 BOOST, Case 180AX Press-fit Pins (Pb-Free)	21 Units / Blister Tray
NXH240B120H3Q1SG	NXH240B120H3Q1SG	Q1 BOOST, Case 180BQ Solder Pins (Pb-Free)	21 Units / Blister Tray

# MECHANICAL CASE OUTLINE

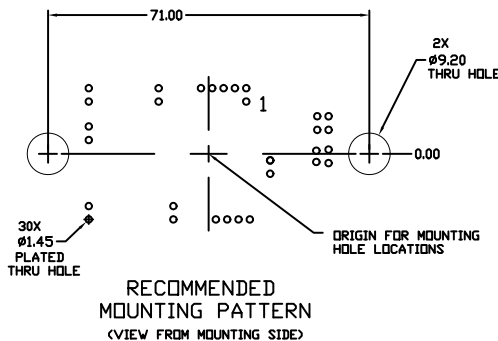
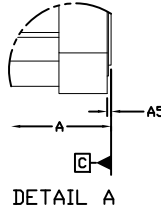
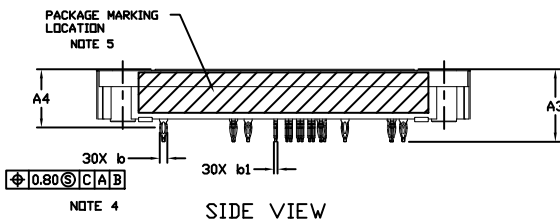
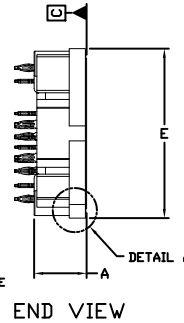
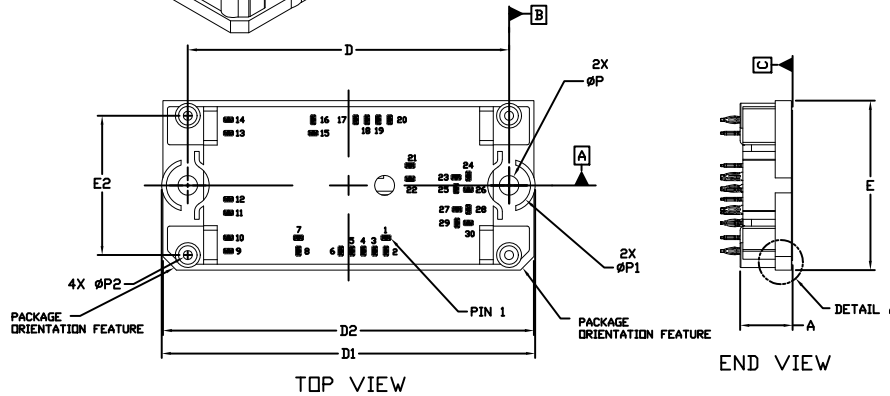
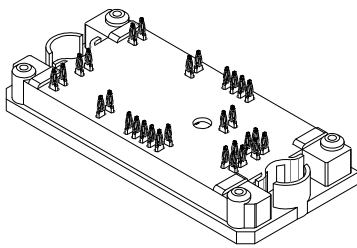
## PACKAGE DIMENSIONS

ON Semiconductor®



PIM30, 71x37.4  
CASE 180AD  
ISSUE E

DATE 28 NOV 2017



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- CONTROLLING DIMENSION: MILLIMETERS
- DIMENSIONS b AND b1 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A4.
- POSITION OF THE CENTER OF THE TERMINALS IS DETERMINED FROM DATUM B THE CENTER OF DIMENSION D, X DIRECTION, AND FROM DATUM A, Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH DIRECTIONS.
- PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES.

MOUNTING HOLE POSITION			MOUNTING HOLE POSITION		
PIN	X	Y	PIN	X	Y
1	8.30	11.55	16	-7.800	-14.50
2	8.30	14.50	17	1.60	-14.50
3	5.80	14.50	18	4.10	-14.50
4	3.30	14.50	19	6.60	-14.50
5	0.80	14.50	20	9.10	-14.50
6	-1.70	14.50	21	13.60	-4.40
7	-11.05	11.55	22	13.60	-1.45
8	-11.05	14.50	23	23.80	-1.80
9	-26.50	14.50	24	26.50	-2.05
10	-26.50	11.55	25	23.80	0.70
11	-26.50	6.05	26	26.50	0.95
12	-26.50	3.05	27	24.00	5.30
13	-26.50	-11.55	28	26.50	5.30
14	-26.50	-14.50	29	24.00	8.30
15	-7.80	-11.55	30	26.50	8.30

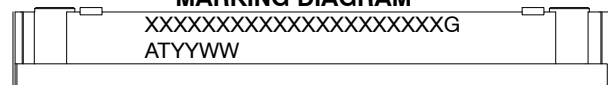
NOTE 4

DIM	MILLIMETERS	
	MIN.	NOM.
A	11.10	12.10
A3	15.50	16.50
A4	12.88	BSC
A5	0.00	0.45
b	1.61	1.71
b1	0.75	0.85
D	70.50	71.50
D1	82.00	83.00
D2	81.50	82.50
E	36.90	37.90
E2	30.30	31.30
P	4.30	4.50
P1	9.30	9.70
P2	1.90	2.10

PIN	PIN POSITION		PIN	PIN POSITION	
	X	Y		X	Y
1	8.30	-11.55	16	-7.800	14.50
2	8.30	-14.50	17	1.60	14.50
3	5.80	-14.50	18	4.10	14.50
4	3.30	-14.50	19	6.60	14.50
5	0.80	-14.50	20	9.10	14.50
6	-1.70	-14.50	21	13.60	4.40
7	-11.05	-11.55	22	13.60	1.45
8	-11.05	-14.50	23	23.80	1.80
9	-26.50	-14.50	24	26.50	2.05
10	-26.50	-11.55	25	23.80	-0.70
11	-26.50	-6.05	26	26.50	-0.95
12	-26.50	-3.05	27	24.00	-5.30
13	-26.50	11.55	28	26.50	-5.30
14	-26.50	14.50	29	24.00	-8.30
15	-7.80	11.55	30	26.50	-8.30

GENERIC

MARKING DIAGRAM\*



XXXXX = Specific Device Code  
G = Pb-Free Package  
AT = Assembly & Test Site Code  
YYWW = Year and Work Week Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	PIM30 71X37.4 (PRESS FIT)	PAGE 1 OF 1

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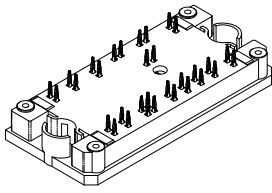
# MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS

ON Semiconductor®



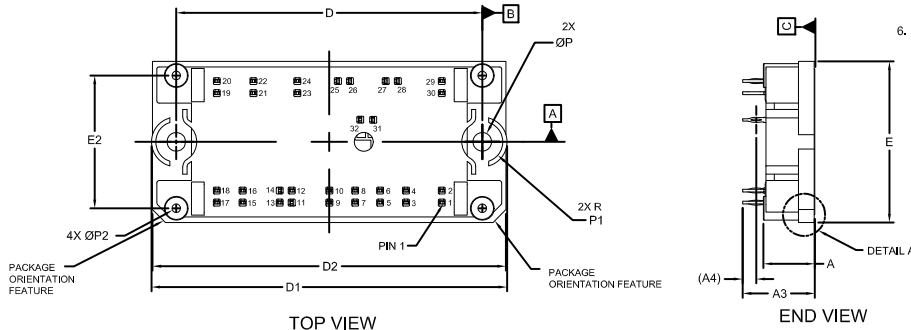
## PIM32, 71x37.4 (PRESS-FIT) CASE 180AX ISSUE O

DATE 25 JAN 2019

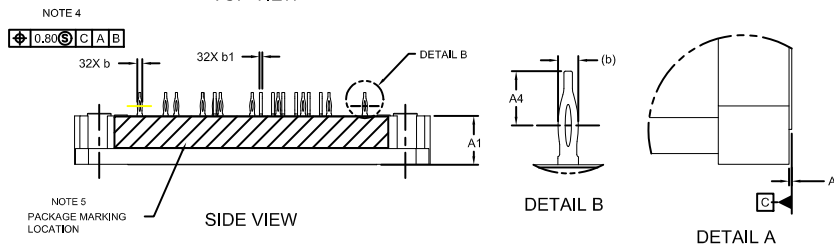


NOTES:

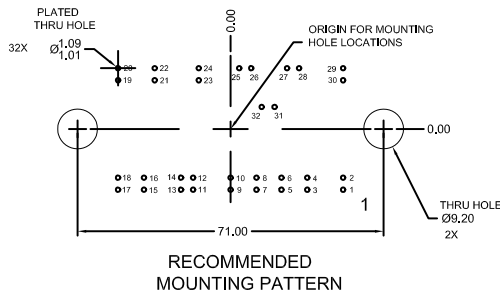
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. DIMENSIONS b AND b1 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A4.
4. POSITION OF THE CENTER OF THE TERMINALS AND MOUNTING HOLES IS DETERMINED FROM DATUM B THE CENTER OF DIMENSION D, X DIRECTION, AND FROM DATUM A, Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED IN DRAWING, APPLIES TO BOTH TERMINALS AND MOUNTING HOLES IN BOTH DIRECTIONS.
5. PACKAGE MARKING IS LOCATED, AS SHOWN, ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES.
6. MOUNTING RECOMMENDATION IS SHOWN AS VIEWED FROM THE PCB TOP LAYER LOOKING DOWN TO SUBSEQUENT LAYERS.



DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	11.44	11.94	12.44
A1	10.84	11.34	11.84
A3	16.27	16.77	17.27
A4	3.05	3.15	3.25
A5	0.04	0.24	0.44
b	1.13	1.18	1.23
b1	0.59	0.64	0.69
D	70.50	71.00	71.50
D1	82.00	82.50	83.00
D2	81.50	82.00	82.50
E	36.90	37.40	37.90
E2	30.30	30.80	31.30
P	4.30	4.40	4.50
P1	4.55	4.75	4.95
P2	2.00 REF		



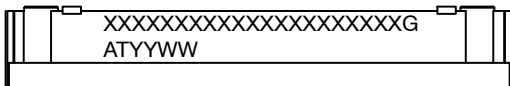
NOTE 5  
PACKAGE MARKING LOCATION



NOTE 4

PIN	PIN POSITION		PIN	PIN POSITION	
	X	Y		X	Y
1	26.10	-14.10	17	-26.10	-14.10
2	26.10	-11.30	18	-26.10	-11.30
3	17.80	-14.10	19	-26.10	11.30
4	17.80	-11.30	20	-26.10	14.10
5	11.80	-14.10	21	-17.60	11.30
6	11.80	-11.30	22	-17.60	14.10
7	6.00	-14.10	23	-7.40	11.30
8	6.00	-11.30	24	-7.40	14.10
9	0.00	-14.10	25	2.00	14.10
10	0.00	-11.30	26	4.80	14.10
11	-8.70	-14.10	27	13.10	14.10
12	-8.70	-11.30	28	15.90	14.10
13	-11.50	-14.10	29	26.10	14.10
14	-11.50	-11.30	30	26.10	11.30
15	-20.10	-14.10	31	10.20	5.10
16	-20.10	-11.30	32	7.20	5.10

### GENERIC MARKING DIAGRAM\*



XXXXX = Specific Device Code  
G = Pb-Free Package  
AT = Assembly & Test Site Code  
YYWW = Year and Work Week Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "▪", may or may not be present. Some products may not follow the Generic Marking.

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